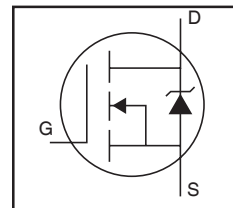


**IRF2903ZPbF**

**HEXFET® Power MOSFET**

**Features**

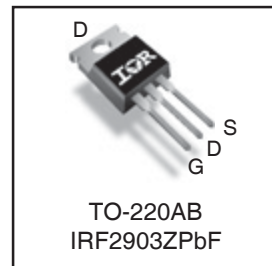
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free



|                           |
|---------------------------|
| $V_{DSS} = 30V$           |
| $R_{DS(on)} = 2.4m\Omega$ |
| $I_D = 75A$               |

**Description**

This HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in a wide variety of applications.



|          |          |          |
|----------|----------|----------|
| <b>G</b> | <b>D</b> | <b>S</b> |
| Gate     | Drain    | Source   |

**Absolute Maximum Ratings**

|                              | Parameter  | Max.                     | Units |
|------------------------------|--|--------------------------|-------|
| $I_D @ T_C = 25^\circ C$     | Continuous Drain Current, $V_{GS} @ 10V$ (Silicon Limited) | 260                      | A     |
| $I_D @ T_C = 100^\circ C$    | Continuous Drain Current, $V_{GS} @ 10V$ (Silicon Limited) | 180                      |       |
| $I_D @ T_C = 25^\circ C$     | Continuous Drain Current, $V_{GS} @ 10V$ (Package Limited) | 75                       |       |
| $I_{DM}$                     | Pulsed Drain Current ①                                     | 1020                     |       |
| $P_D @ T_C = 25^\circ C$     | Power Dissipation  | 290                      | W     |
|                              | Linear Derating Factor                                     | 2.0                      | W/°C  |
| $V_{GS}$                     | Gate-to-Source Voltage                                     | $\pm 20$                 | V     |
| $E_{AS}$ (Thermally limited) | Single Pulse Avalanche Energy ②                            | 290                      | mJ    |
| $E_{AS}$ (Tested)            | Single Pulse Avalanche Energy Tested Value ③               | 820                      |       |
| $I_{AR}$                     | Avalanche Current ④  | See Fig.12a, 12b, 15, 16 | A     |
| $E_{AR}$                     | Repetitive Avalanche Energy ⑤                              |                          | mJ    |
| $T_J$                        | Operating Junction and                                     | -55 to + 175             | °C    |
| $T_{STG}$                    | Storage Temperature Range                                  |                          |       |
|                              | Soldering Temperature, for 10 seconds                      | 300 (1.6mm from case)    |       |
|                              | Mounting Torque, 6-32 or M3 screw ⑦                        | 10 lbf•in (1.1N•m)       |       |

**Thermal Resistance**

|                 | Parameter                             | Typ. | Max. | Units |
|-----------------|---------------------------------------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case ⑧                    | —    | 0.51 | °C/W  |
| $R_{\theta CS}$ | Case-to-Sink, Flat, Greased Surface ⑨ | 0.50 | —    |       |
| $R_{\theta JA}$ | Junction-to-Ambient ⑩                 | —    | 62   |       |

# IRF2903ZPbF

International  
**IR** Rectifier

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

|                                 | Parameter                            | Min. | Typ.  | Max. | Units | Conditions   |
|---------------------------------|--------------------------------------|------|-------|------|-------|--|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 30   | —     | —    | V     | $V_{GS} = 0V, I_D = 250\mu A$                        |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.021 | —    | V/°C  | Reference to $25^\circ\text{C}, I_D = 1mA$           |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | 1.9   | 2.4  | mΩ    | $V_{GS} = 10V, I_D = 75A$ ③                          |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.0  | —     | 4.0  | V     | $V_{DS} = V_{GS}, I_D = 150\mu A$                    |
| gfs                             | Forward Transconductance             | 120  | —     | —    | S     | $V_{DS} = 10V, I_D = 75A$                            |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —     | 20   | μA    | $V_{DS} = 30V, V_{GS} = 0V$                          |
|                                 |                                      | —    | —     | 250  |       | $V_{DS} = 30V, V_{GS} = 0V, T_J = 125^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —     | 200  | nA    | $V_{GS} = 20V$                                       |
|                                 | Gate-to-Source Reverse Leakage       | —    | —     | -200 |       | $V_{GS} = -20V$                                      |
| $Q_g$                           | Total Gate Charge                    | —    | 160   | 240  | nC    | $I_D = 75A$  |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | 51    | —    |       | $V_{DS} = 24V$                                       |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | 58    | —    |       | $V_{GS} = 10V$ ③                                     |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 24    | —    | ns    | $V_{DD} = 15V$                                       |
| $t_r$                           | Rise Time                            | —    | 100   | —    |       | $I_D = 75A$  |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 48    | —    |       | $R_G = 3.2\ \Omega$                                  |
| $t_f$                           | Fall Time                            | —    | 37    | —    |       | $V_{GS} = 10V$ ③                                     |
| $L_D$                           | Internal Drain Inductance            | —    | 4.5   | —    | nH    | Between lead,<br>6mm (0.25in.)                       |
| $L_S$                           | Internal Source Inductance           | —    | 7.5   | —    |       | from package<br>and center of die contact            |
| $C_{iss}$                       | Input Capacitance                    | —    | 6320  | —    | pF    | $V_{GS} = 0V$  |
| $C_{oss}$                       | Output Capacitance                   | —    | 1980  | —    |       | $V_{DS} = 25V$                                       |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 1100  | —    |       | $f = 1.0MHz$   |
| $C_{oss}$                       | Output Capacitance                   | —    | 5930  | —    |       | $V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$             |
| $C_{oss}$                       | Output Capacitance                   | —    | 2010  | —    |       | $V_{GS} = 0V, V_{DS} = 24V, f = 1.0MHz$              |
| $C_{oss\ eff.}$                 | Effective Output Capacitance         | —    | 3050  | —    |       | $V_{GS} = 0V, V_{DS} = 0V\ to\ 24V$ ④                |

## Source-Drain Ratings and Characteristics

|          | Parameter                                 | Min.  | Typ. | Max. | Units | Conditions  |
|----------|---|---|------|------|-------|---|
| $I_S$    | Continuous Source Current<br>(Body Diode) | —   | —    | 75   | A     | MOSFET symbol<br>showing the<br>integral reverse<br>p-n junction diode. |
| $I_{SM}$ | Pulsed Source Current<br>(Body Diode) ①   | —   | —    | 1020 |       |   |
| $V_{SD}$ | Diode Forward Voltage                     | —   | —    | 1.3  | V     | $T_J = 25^\circ\text{C}, I_S = 75A, V_{GS} = 0V$ ③                      |
| $t_{rr}$ | Reverse Recovery Time                     | —   | 34   | 51   | ns    | $T_J = 25^\circ\text{C}, I_F = 75A, V_{DD} = 15V$                       |
| $Q_{rr}$ | Reverse Recovery Charge                   | —   | 29   | 44   | nC    | $di/dt = 100A/\mu s$ ③  |
| $t_{on}$ | Forward Turn-On Time                      | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ ) |      |      |       |   |

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Limited by  $T_{Jmax}$ , starting  $T_J = 25^\circ\text{C}, L = 0.10mH, R_G = 25\Omega, I_{AS} = 75A, V_{GS} = 10V$ . Part not recommended for use above this value.
- ③ Pulse width  $\leq 1.0ms$ ; duty cycle  $\leq 2\%$ .
- ④  $C_{oss\ eff.}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑤ Limited by  $T_{Jmax}$ , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- ⑥ This value determined from sample failure population. 100% tested to this value in production.
- ⑦ This is only applied to TO-220AB package.
- ⑧  $R_{\theta}$  is measured at  $T_J$  approximately  $90^\circ\text{C}$

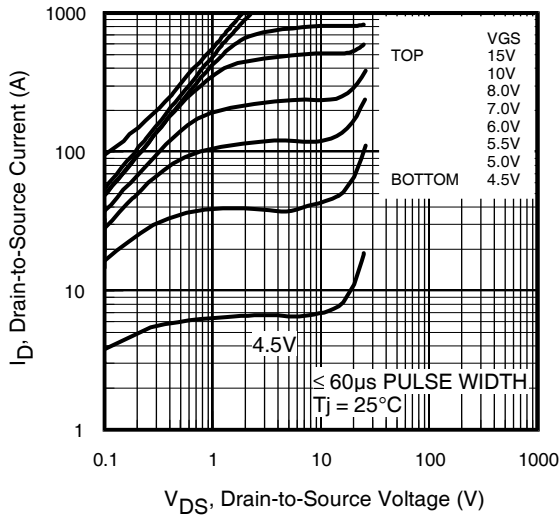


Fig 1. Typical Output Characteristics

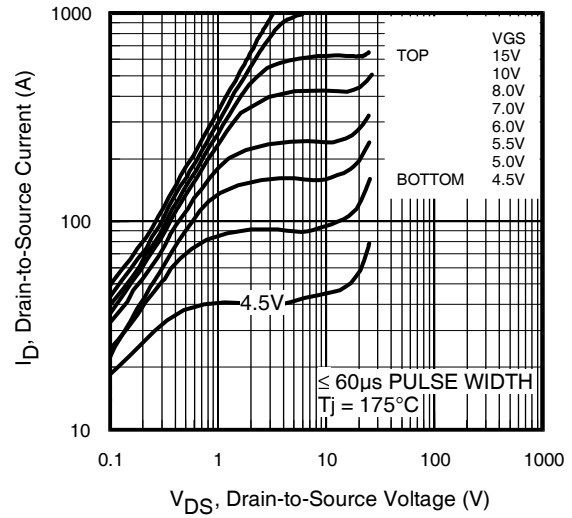


Fig 2. Typical Output Characteristics

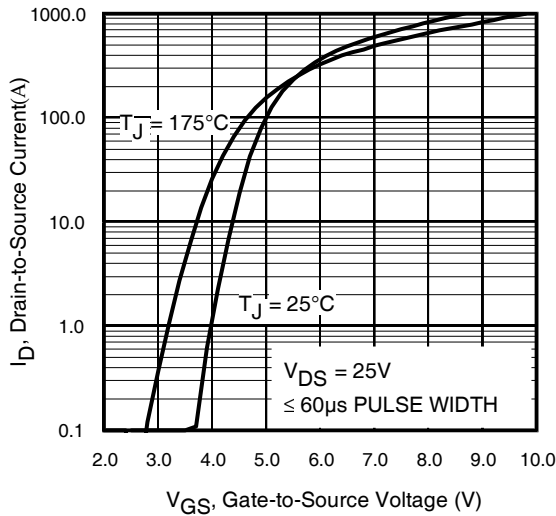


Fig 3. Typical Transfer Characteristics

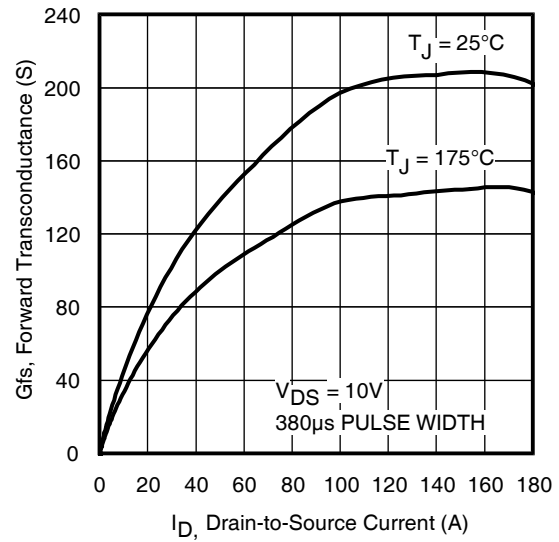
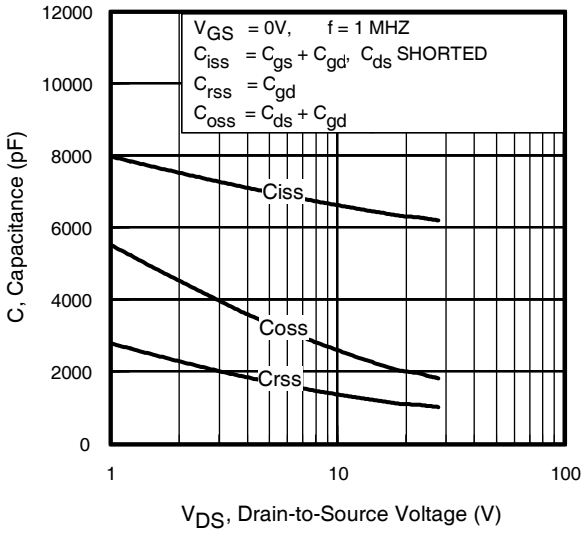


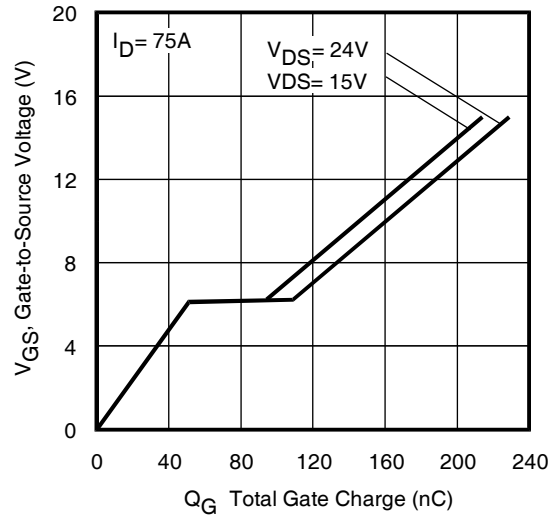
Fig 4. Typical Forward Transconductance Vs. Drain Current

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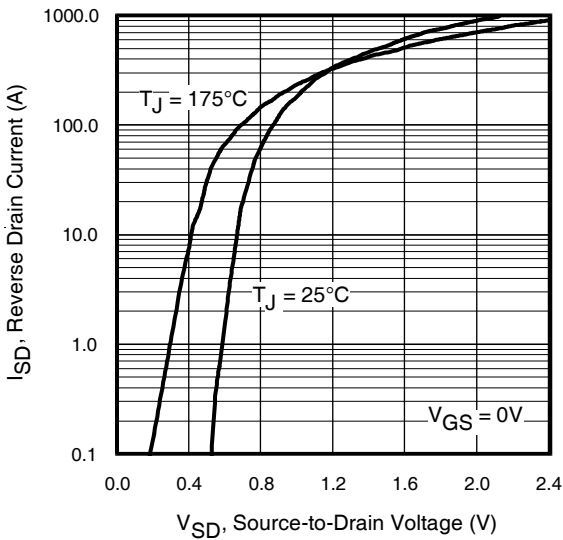
International  
**IR** Rectifier



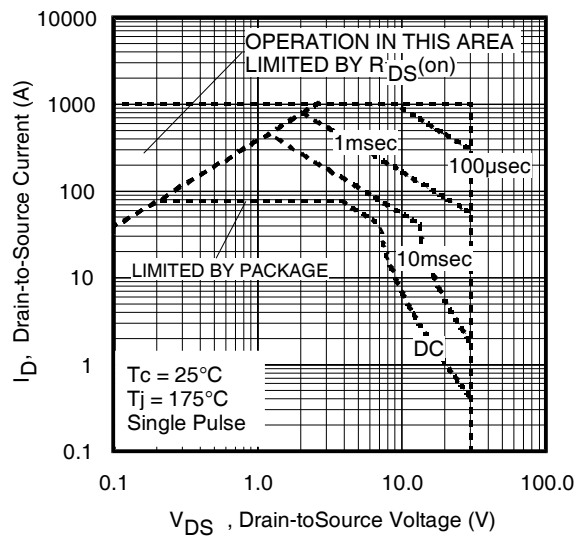
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



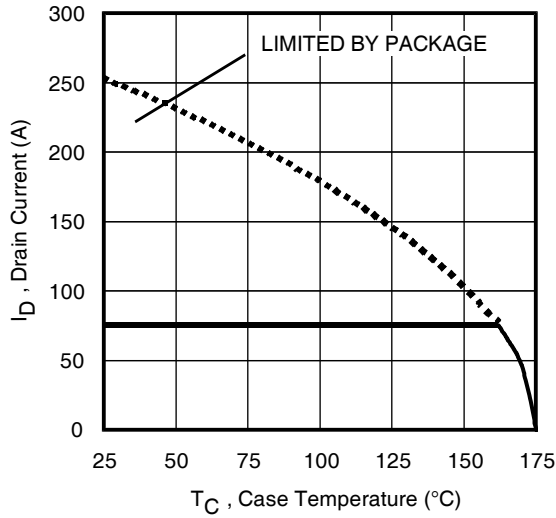
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



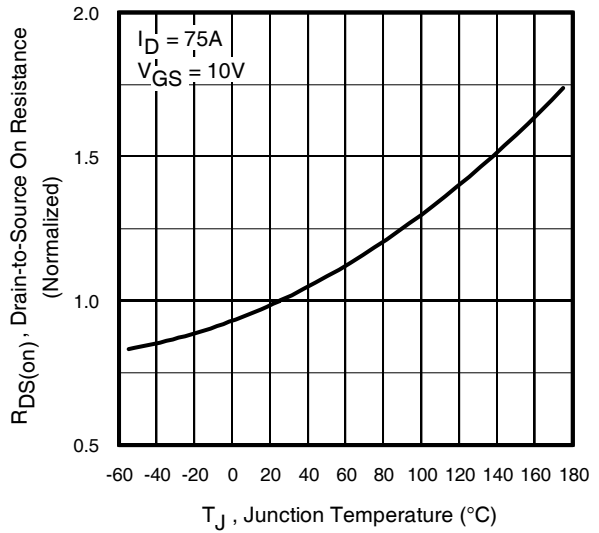
**Fig 7.** Typical Source-Drain Diode Forward Voltage



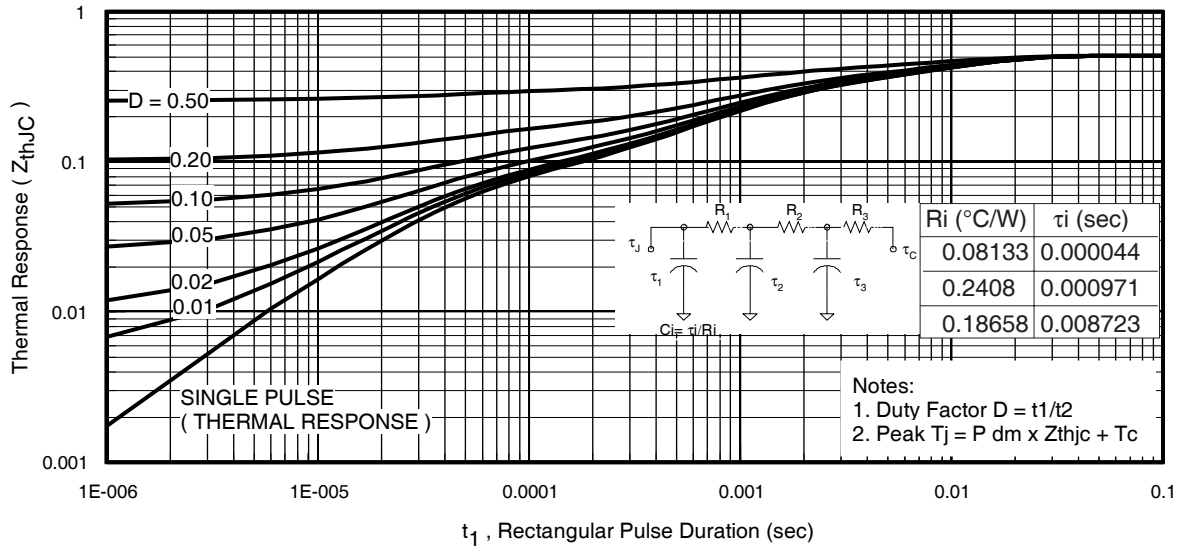
**Fig 8.** Maximum Safe Operating Area



**Fig 9.** Maximum Drain Current Vs. Case Temperature



**Fig 10.** Normalized On-Resistance Vs. Temperature



**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

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**IR** Rectifier



**Fig 12a.** Unclamped Inductive Test Circuit



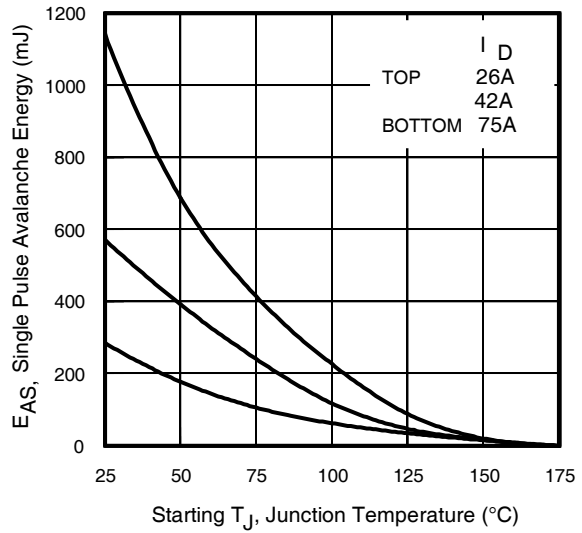
**Fig 12b.** Unclamped Inductive Waveforms



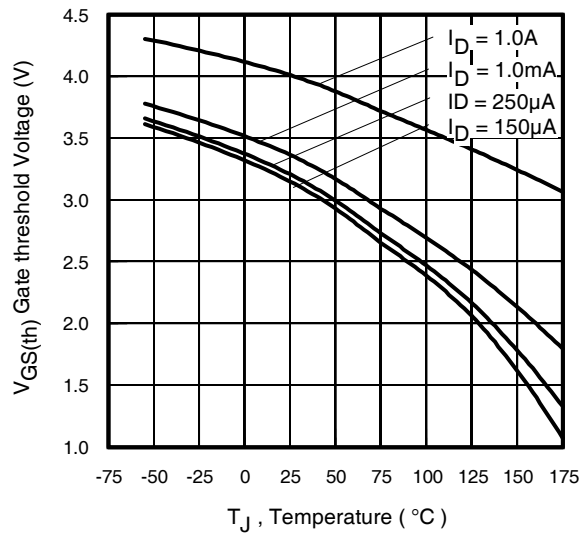
**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 14.** Threshold Voltage Vs. Temperature

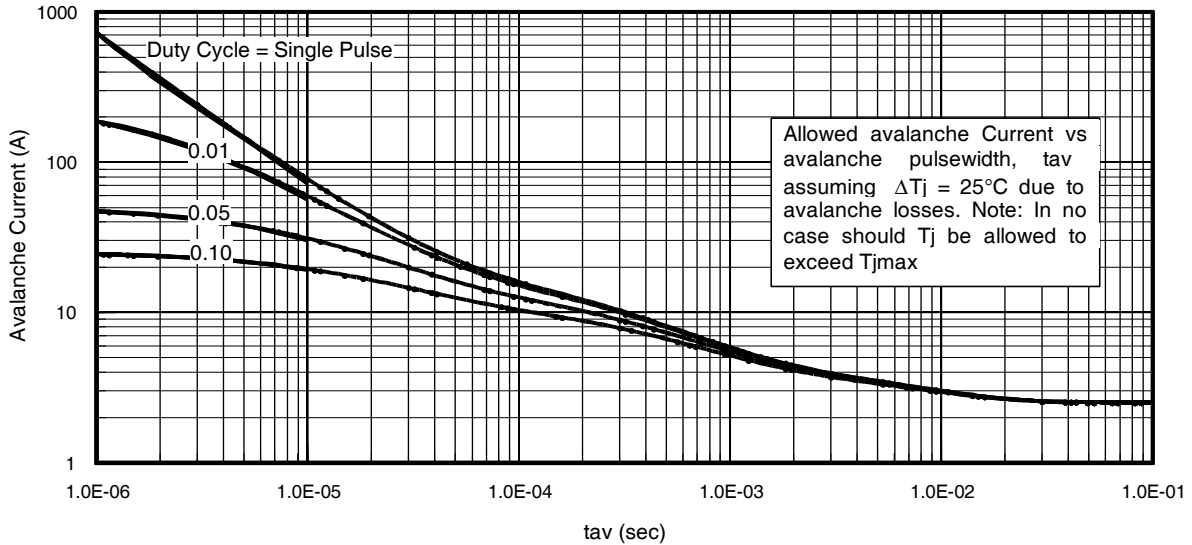


Fig 15. Typical Avalanche Current Vs.Pulsewidth

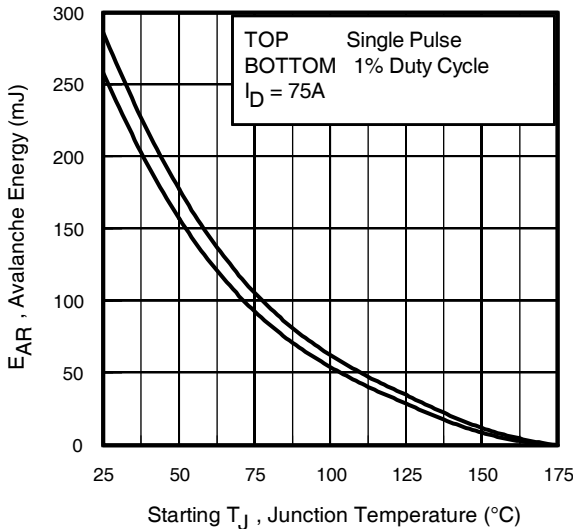


Fig 16. Maximum Avalanche Energy Vs. Temperature

**Notes on Repetitive Avalanche Curves , Figures 15, 16:**  
(For further info, see AN-1005 at [www.irf.com](http://www.irf.com))

1. Avalanche failures assumption:  
Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
4.  $P_{D(ave)}$  = Average power dissipation per single avalanche pulse.
5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 15, 16).  
 $t_{av}$  = Average time in avalanche.  
 $D$  = Duty cycle in avalanche =  $t_{av} \cdot f$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see figure 11)

$$P_{D(ave)} = 1/2 ( 1.3 \cdot BV \cdot I_{av} ) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$



**Fig 17. Peak Diode Recovery  $dv/dt$  Test Circuit for N-Channel HEXFET® Power MOSFETs**



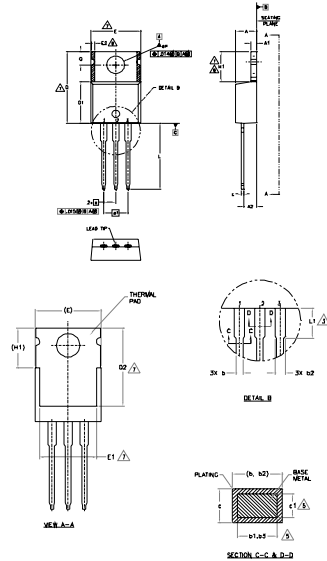
**Fig 18a. Switching Time Test Circuit**



**Fig 18b. Switching Time Waveforms**



TO-220AB Package Outline (Dimensions are shown in millimeters (inches))



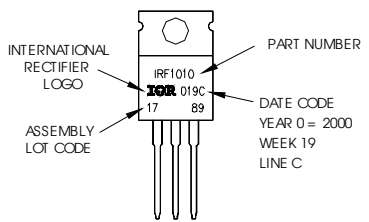
NOTES  
 1- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M-1994.  
 2- DIMENSIONS ARE SHOWN IN INCHES (MILLIMETERS).  
 3- LEAD DIMENSIONS AND FLASH UNCONTROLLED IN L.S.  
 4- DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .002" (0.077) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY. DIMENSION D1, D2 & E APPLY TO BASE METAL ONLY.  
 5- CONTROLLING DIMENSION - INCHES.  
 6- INTERNAL AND CONTOUR ORIGINAL DIMENSIONS EXCEPT A1 & E1.  
 7- DIMENSION E2 IS NOT OFFLINE A ZONE WHERE STAMPING AND PRODUCTION VARIATIONS ARE ALLOWED.  
 8- OUTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (max.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE.

| SYMBOL | DIMENSIONS  |       |        |      | NOTES |
|--------|-------------|-------|--------|------|-------|
|        | MILLIMETERS |       | INCHES |      |       |
|        | MIN.        | MAX.  | MIN.   | MAX. |       |
| A      | 3.55        | 4.83  | .140   | .190 |       |
| A1     | 0.51        | 1.40  | .020   | .056 |       |
| A2     | 2.03        | 2.92  | .080   | .115 |       |
| b      | 0.28        | 1.01  | .015   | .040 |       |
| b1     | 0.38        | 0.97  | .015   | .038 | 5     |
| b2     | 1.14        | 1.78  | .045   | .070 |       |
| b3     | 1.14        | 1.73  | .045   | .068 | 5     |
| c      | 0.36        | 0.61  | .014   | .024 |       |
| c1     | 0.36        | 0.56  | .014   | .022 | 5     |
| D      | 14.22       | 16.51 | .560   | .650 | 4     |
| D1     | 8.38        | 9.02  | .330   | .355 | 7     |
| D2     | 11.88       | 12.28 | .460   | .507 | 4,7   |
| E      | 9.65        | 10.67 | .380   | .420 | 7     |
| E1     | 6.96        | 8.89  | .270   | .350 | 7     |
| E2     | 0.76        | -     | .030   | -    | 8     |
| e      | 2.54        | 2.54  | .100   | .100 |       |
| e1     | 2.54        | 2.54  | .100   | .100 |       |
| ef     | 4.94        | 6.96  | .240   | .270 | 7,8   |
| hf     | 12.70       | 14.73 | .500   | .580 |       |
| L      | 3.56        | 4.06  | .140   | .160 | 3     |
| MP     | 3.24        | 4.06  | .129   | .161 |       |
| Q      | 2.54        | 3.42  | .100   | .135 |       |

LEAD FINISHES  
 1- GATE  
 2- BUMP  
 3- TUMBLE  
 4- NONE  
 5- PLATE  
 6- NONE  
 7- NONE  
 8- NONE

TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010  
 LOT CODE 1789  
 ASSEMBLED ON WW 19, 2000  
 IN THE ASSEMBLY LINE "C"  
 Note: "P" in assembly line position  
 indicates "Lead-Free"



TO-220AB package is not recommended for Surface Mount Application.

- Notes:
1. For an Automotive Qualified version of this part please see <http://www.irf.com/product-info/auto/>
  2. For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Data and specifications subject to change without notice.  
 This product has been designed and qualified for the Industrial market.  
 Qualification Standards can be found on IR's Web site.

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[NTE2967](#) [NTE2969](#) [NTE2976](#) [NTE6400A](#) [NTE2910](#) [NTE2916](#) [NTE2956](#) [NTE2911](#) [DMN2080UCB4-7](#) [TK10A80W,S4X\(S](#)  
[SSM6P69NU,LF](#) [DMP22D4UFO-7B](#) [DMN1006UCA6-7](#)